Docket No.

248684US2SRD

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Masahiro KOIKE, et al.

SERIAL NO: New Application

GAU:

FILED:

Herewith

EXAMINER:

FOR:

SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING SEMICONDUCTOR DEVICE

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- □ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number <u>15-0030</u>. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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LIST OF RELATED CASES

Serial or Filing or Inventor/
Docket Number Patent Number Issue Date Applicant

246244US2 SRD 10/726,606 12/04/03 KOYAMA et al.

DOCKET NO.: 248684US2SRD

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STATEMENT OF RELEVANCY

Reference AW on Form PTO 1449:

This reference relates to HfSiON films. Their films contain Hf/(Hf+Si) of less than 47%. But, this reference doesn't mention about Hf-N bonds. Due to the low Hf concentrations in the films, their films don't include Hf-N bonds.

Our HfSiON films contain Hf/(Hf+Si) of more than 47% and include a large amount of Hf-N bonds which enhance the dielectric constant up to 24 in HfSiON with Hf/(Hf+Si) of 80% and N of 35%.

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE				ATTY DOCKET NO.		SERIAL NO.			
(Modified) PATENT AND TRADEMARK OFFICE			248684US2SRD		New Application				
				APPLICANT					
LIST OF REFERENCES CITED BY APPLICANT				Masahiro KOIKE, et al.					
				FILING DATE		GROUP			
				Herewith					
U.S. PATENT DOCUMENTS									
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
	AW	M. R. VISOKAY, et al., "APPLICATION OF HISION AS A GATE DIELECTRIC MATERIAL", Applied Physics Letters, Vol. 80, No. 17, April 29, 2002, pgs. 3183-3185							
	АХ								
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-	AZ				Add	Additional References sheet(s) attached			
Examiner					Date Considered				
*Examiner: In	nitial if r	reference is considered, ot considered. Include co	whether or no	ot citation is in conformance with MPEP 60 n with next communication to applicant.	09; Draw I	ine through	citation	if not in	